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List of Contents, Volume 53, 1996

Electrical Double Layers at the Oil/Water Interface 1
A. G. VOLKOV, D. W. DEAMER, D. L. TANELIAN and
V. S. MARKIN

Proceedings of the 18th International Seminar on Surface Physics 135

Part 1 — Jochen H. Block Memorial Session
Part 2 — Photoemission
Part 3 — Adsorption and Desorption
Part 4 — Diffusion
Part 5 — Scattering
Part 6 — Atomic Structure/Composition
Part 7 — Clusters
Part 8 — Other Topics

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PROGRESS IN SURFACE SCIENCE

AUTHOR INDEX

Amos, A. T. 323
Bartynski, R. A. 155
Bonzel, H. P. 287
Borziak, P. G. 171
Brajczewska, M. 305
Budde, K. 205
Burrows, B. L. 323
Coenen, P. 287
Colonna, S. 253
Dan'Ko, D. B. 171
Davison, S. G. 323
Davoli, I. 253
Deamer, D. W. 1
De Crescenzi, M. 253
Deymier, P. A. 179
Djafari-Rouhani, B. 179
Dobrzynski, L. 179
English, R. E. 323
Ernst, N. 135
Fanfoni, M. 253
Fedorovich, R. D. 171
Fiolhais, C. 305, 315
Fu, T. Y. 233
Goodman, F. O. 323
Greber, T. 163
Gross, A. 187
Gunnella, R. 253
Henriques, C. 315
Hulbert, S. L. 155
Jankowski, Z. 197
Jensen, E. 155
Kao, C.-C. 155
Kellogg, G. L. 217
Kiyaev, O. E. 171
Kreuzer, H. J. 135
Markin, V. S. 1
Medvedev, V. K. 135
Miskovic, Z. L. 323
Modisette, J. P. 265
Moresco, F. 331
Mróz, S. 197
Mullins, W. W. 287
Naumovets, A. G. 171
Nogueira, F. 315
Nordlander, P. 265
Nowicki, M. 197
Osterwalder, J. 163
Oumghar, E. 179
Perdew, J. P. 305
Pfnür, H. 205
Rocca, M. 331
Scheffler, M. 187
Schmidt, W. A. 135
Schwenger, L. 205
Soszka, W. 273
Suchorski, Y. 135
Surnev, S. 287
Tanelian, D. L. 1
Tringides, M. C. 225
Tsong, T. T. 233
Turski, L. A. 241
Uebing, C. 297
Vasseur, J. O. 179
Vieira, A. 305
Voges, C. 205
Volkov, A. G. 1
Wang, R. L. C. 135

PII: S0079-6816(98)00011-2

PROGRESS IN SURFACE SCIENCE

SUBJECT INDEX

Activation energy
  see also field desorption energy
  field desorption, Li from W(111) 139–141
  field evaporation, rhodium 150–152
Adlayers
  critical phenomena, defect influence 205–214
  phase transitions, defect influence 205–214
Adsorbed polymers, models 180–185
Adsorption
  dissociative
    ro-vibrational effects H2/Pd(100) 187–195
    steering effects H2/Pd(100) 187–195
  Freundlich isotherm 49
  Frumkin isotherm 51
  Henry isotherm 49
  Langmuir isotherm 49
  p(2x2) oxygen, on stepped Ru(0001) 214
  polymers
    one-dimensional substrate 180–183
    three dimensional substrate 183–185
  specific, liquid interfaces 35–44
Adsorption isotherms, interfaces 44–56
Aluminium, clusters 305–312
Amphiphilic compounds, adsorption isotherms 41, 44–56
APECS *see* Auger-photoelectron coincidence spectroscopy
Auger decay, core-valence-valence (CVV) 156
Auger-photoelectron coincidence spectroscopy (APECS) 156–158
  copper(100) spectra 158–161
Autoionization, Compton inelastic scattering 260–263

Backscattering, secondary electrons, extended fine-structure 253–263
Barium oxide, evaporation, IFs 173–174
Binding energy
  field desorption, Li from W(111) 139–141
  field evaporation, rhodium 150–152
  ledge atoms, surface step structures 237–238
Born, Max, solvation 72–80

Capacitance
  ITIES 14–23
  liquid double-layers
    ITIES 23–29
    Parsons-Zobel dependencies 29–32
CEJ *see* cluster embedded in jellium
Charge-transfer theory 265–272
Cluster embedded in jellium (CEJ) 136, 144, 149, 152
Clusters
  atomic, surface diffusion 217–223
  energy, liquid drop model (LDM) 307
  evanescent core pseudopotentials 318–320
  simple metal
    charge instability 305–312
    volume shift 305–312
Compton inelastic scattering, autoionization 260–263
Computer simulation, ITIES 111–118
Copper(100), APECS spectra 158–161
Core-valence-valence (CVV) auger decay 156
CVV *see* core-valence-valence (CVV) Auger decay

DAES *see* directional Auger electron spectroscopy
DEPES *see* directional elastic peak electron spectroscopy (DEPES)
Desorption
  associative
    ro-vibrational effects H2/Pd(100) 187–195
    steering effects H2/Pd(100) 187–195
Dielectric permittivity
  double-layer interfaces 71
  variable, interfaces 72–80
Diffusion coefficients
  surface 225–226
    equilibrium vs non-equilibrium 226–227
Directional auger electron spectroscopy (DAES) 197–204
Directional elastic peak electron spectroscopy (DEPES) 197–204
Dispersion
  surface plasmons
    Ag/Pd single crystals 333–337
    measurement 333
    positive 337–339

EAM *see* embedded atom method
ECS *see* equilibrium crystal shape
Edge vacancy diffusion 220–221
EELFS *see* extended energy loss fine structure
Electrocapillary phenomena, liquid interfaces 14–23
Electrolyte solutions, immiscible, interface 4
Electrolytes, immiscible interfaces, electrocapillary properties 14–23
Electron diffraction, EXFAS angular dependence 260
Electron emission
  nanomaterials, adlayer-covered 171–178
  silicon island films 176–177
Electrostatic field, local, enhancement 142–144
ELS *see* energy loss spectroscopy
Embedded atom method (EAM) 209–210, 221
Energy, surface free energy, anisotropic 288–290
Energy loss spectroscopy (ELS) 331–339
Equilibrium crystal shape (ECS) 287–288
Evaporation, silver, from Nickel surface 202–203
EXFAS *see* extended fine autoionization structure
Extended energy loss fine structure (EELFS) 254, 256, 257
Extended fine autoionization structure (EXFAS)
  angular dependence 260
  experimental evidence for 255–257
  theoretical description of 257–260

Fe-Cr-N system cosegregation 298–302
Fe-Si-V-C system cosegregation 302–303
Field desorption
  CEJ model 144
  lithium
    experimental results interpretation 145–146
    Li layer source 145–146
    low coverage 145
    theoretical results 141–144
  particle type 141
Field evaporation
  CEJ model 149
  rhodium
    experimental results interpretation 150–152
    experimental study 147–149
    theoretical results 149–150
Field ion microscopy (FIM), cluster diffusion 217–223
Film thickness, condensed gases 279–284
FIM *see* field ion microscopy (FIM)
Finite barrier model (FBM) 268
Freundlich isotherms 49
Frumkin adsorption isotherm, amphiphilic compounds 44, 51–56

Gold(111), surface morphology experiment 292–295

Gouy-Chapman theory 9, 29
  electric double layer, metal/water interfaces 69–72
  MPB theory contrast 96–97
Gouy-Chapman-Stern theory 69–72
Grahame dependency 29
Green function, causal-surface 324–327

H2/pd(100), adsorption/desorption 187–195
HCA *see* hyperchain approximation
Helmholtz planes
  adsorbed ions 35
  MVN model 7
Henry isotherms 49
High resolution angle resolved electron energy loss spectroscopy (HREELS) 331–339
Holography, photoelectron, suppressed forward scattering 163–169
HREELS *see* high resolution angle resolved electron energy loss spectroscopy
Hydration forces, electric double layers 84–91
Hydrogen, adsorption on Ni(111) 205–214
Hyperchain approximation (HCA) 71, 101

ICISS *see* impact collision ion scattering spectroscopy
IDL *see* independent diffuse layers
IFS *see* island films
Image forces, interfaces 59–69
Impact collision ion scattering spectroscopy (ICISS) 274, 275, 278
Independent diffuse layers (IDL), ITIES contrast 114–118
Interatomic spacing, ISS 274–279
Interface between two immiscible electrolyte solutions (ITIES) 3, 35, 56–59, 114–118
Interface response theory 180
Interfaces
  adsorption isotherms 44–56
  charged, ion-dipole plasma 103–109
  computer simulation, ITIES 111–118
  electrocapillary phenomena 14–23
  image forces 59–69
  ionic plasma 101–103
    continuous dielectric 101–103
  ITIES, ionic association/ligand binding 35
  liquid miscibility 4
  MPB model 99
  polarizable 4–7
  potential distribution, ITIES 8–14
  roughness, ITIES 56–59
  statistical theories 69–72
  structure of, molecular dynamics 118–122
  variable dielectric permittivity 72–80
Ion-dipole plasma, charged interfaces 103–109
Ion-scattering spectroscopy (ISS), large/small angle 273–284
Ionic plasma, continuous dielectric, interfaces 101–103
Island films (IFS) 171
  electron emission, metal overlayer effects 173–176
  electropositive layers 173–174
  light emission, metal overlayer effects 173–176
  organic layers 174–176
  silicon
    electron emission 176–177
    light emission 176–177
ISS *see* ion scattering spectroscopy
ITIES *see* Interface between two immiscible electrolyte solutions (ITIES)

Kharkats-Ulstrup model 61–62
Koenig surfaces 5–7
Kohn-Sham density function theory 306, 318–320

LAISS *see* large-angle ion scattering spectroscopy
Langmuir isotherms 49
Large-angle ion scattering spectroscopy (LAISS) 284
Lattice Boltzmann gas model (LBG) 245
Lattice gas models, surface diffusion 241–242

Lattice steps, surface atom mobility 233–234
LBG *see* lattice Boltzmann gas model
LDA *see* local density approximation
LDM *see* liquid drop model
LEED *see* low energy electron diffraction
Li-FDM *see* lithium field desorption microscope
Light emission, silicon island films 176–177
Liquid drop model (LDM)
  charged cluster energy 307–312
  evanescent core pseudopotentials 320
Lithium, field desorption, from tungsten 136–146
Lithium field desorption microscope (LI-FDM) 137
Local density approximation (LDA) 306, 316, 317, 318
Local reflection matrix (LORE) 189
LORE *see* local reflection matrix
Low energy electron diffraction (LEED), hydrogen adsorption, Ni(111) 207–208

MC *see* Monte Carlo method
Mean spherical approximation (MSA) 71, 101–109
Metal surfaces, low energy ions, multiple scattering 279–284
Microscopes, lithium field desorption microscope (Li-FDM) 137
Microscopy, field ion (FIM), cluster diffusion 217–223
Modified Poisson-Boltzmann (MPB) theory 71, 91–100
Modified Verwey-Niessen model (MVN) 7–14
  development of 69–72
Molecular dynamics, interface structure 118–122
Monte Carlo method (MC), double layers 109–111
Monte Carlo simulation, surface diffusion 228
MPB *see* Modified Poisson-Boltzmann theory
MSA *see* mean spherical approximation
Multiple scattering, low energy ions, cold metal surfaces 279–284
MVN *see* Modified Verwey-Niessen model (MVN)

Nanomaterials, adlayer covered, photon/electron emissions 171–178
Non-local electrostatics 80–84

Oxygen, p(2x2), on stepped Ru(0001) 214

Parsons-Zobel dependencies 29–32
PES *see* potential energy surface
Phase transitions
  isotope effects, hydrogen on Ni(111) 208–210
  oxygen impurity effects, hydrogen on Ni(111) 210–213
Photoelectron diffraction 163
Photoelectron holography 163–169
Photon emission, nanomaterials, adlayer-covered 171–178
Platinum, cluster diffusion, Rh(100) surface 218–223
Polymers, adsorbed, vibrational properties 179–186
Potential discontinuities, compact layers 32–35
Potential energy surface (PES), H2/Pd(100) 188–189
Potentials, immiscible interfaces, zero free charge 14–23
Potentiostats, four-electrode, double-layer capacitance measurement 23–29
Pseudopotentials, evanescent core 315–321

Recursive green-function method (RGFM) 323–330
RGFM *see* recursive Green-function method (RGFM)
Rhodium
  cluster diffusion, Rh(100) surface 218–223
  field evaporation of 147–152
Rydberg atoms, interactions, metal surfaces 266–268

Scanning tunnel microscopy (STM),
surface diffusion 228
SDOS *see* surface density of states
(SDOS)
Silver
crystalline structure, ultrathin layers
200–201
evaporation, Ni surface 202–203
layer dissolution, Cu substrate
101–102
layer growth 199–200
SJM *see* stabilized jellium model
Sodium, clusters 305–312
Solvation, Born's theory 72–80
Spectroscopy
APECS 156–158
APECS spectra, copper(100) 158–161
appearance energy
field desorbed Li+ ions 136–139
field evaporated Rh2+ ions
147–149
DEAS 197–204
DEPES 197–204
ELS 331–339
EXFAS 255–257
HREELS 331–339
ion-scattering, large/small angle
273–284
large-angle ion scattering
spectroscopy (LAISS) 284
Stabilized jellium model (SJM) 305–307,
317–321
Stearone, evaporation, IFs 174–176
Step structures, surface layers 235
STM *see* scanning tunnel microscopy
Surface cosegregation, alloys/steels
297–303
Surface density of states (SDOS) 323
Surface diffusion 225–231
cluster 218–220
d=2+1 dynamics 241–251
edge atoms 220–221
ledge atoms 235
step-edge atoms, ascending motion
238–239
stepped surfaces 233–239
Surface morphologies,
equilibrium/transient 287–295
Surface plasmons, HREELS/ELS studies,
Ag/Pd single crystals 331–339
Surface profiles, modulated vicinal
surfaces 290–292
Surface structures
ledge atoms, binding energy 237–238
nanometer sized islands, equilibrium
shape 236–237
Surface Wannier-Stark band (SWSB)
327–329
Surfaces
atomic energy levels 266–271
equilibrium morphologies 287–295
evanescent core pseudopotentials
317–318
Surfactant size, adsorption isotherms 52
SWSB *see* surface Wannier-Stark band

Thermal desorption, particle type 141
Thermodynamic charge potential 14–23
Thin films
dielectric, negative ion interaction
268–271
dispersed 171
see also IFs
epitaxial growth modes 233–234

Ultrathin layers
silver
on copper 197–204
on Nickel 197–204

Wannier-Stark effect, surface states
323–330

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Tables of Contents by e-mail

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